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Application/Control No. 10/723,387	Applicant(s)/Patent Under Reexamination SIMMONS ET AL.		
Examiner	Art Unit		
Robert H. Spitzer	1724	Page 1 of 4	

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Application/Control No. 10/723,387	Applicant(s)/Patent Under Reexamination SIMMONS ET AL.		
Examiner	Art Unit		
Robert H. Spitzer	1724	Page 2 of 4	

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## Notice of References Cited Application/Control No. 10/723,387 Applicant(s)/Patent Under Reexamination SIMMONS ET AL. Examiner Robert H. Spitzer Art Unit Page 3 of 4

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